Application/Control No. Applicant(s)/Patent Under Reexamination 10/828,814 SCHOTTEK ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Rip A. Lee 1713 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY * 02-2001 US-6,184,402 B1 Yamazaki et al. 556/11 Α * US-6,960,676 B2 В 11-2005 Rix et al. 556/87 08-1999 С US-5,945,367 A Thiele et al. 502/155 * US-4,985,576 01-1991 Rohrmann et al. D 556/435 US-6,365,763 B1 04-2002 Winter et al. Ε 556/11 US-F US-G US-Н US-1 US-J USĸ US-L US-М **FOREIGN PATENT DOCUMENTS** Date **Document Number** Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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